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What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "Embedded - Microcontrollers"

Details	
Product Status	Obsolete
Core Processor	Coldfire V2
Core Size	32-Bit Single-Core
Speed	66MHz
Connectivity	CANbus, EBI/EMI, Ethernet, I²C, QSPI, UART/USART, USB OTG
Peripherals	DMA, LVD, POR, PWM, WDT
Number of I/O	96
Program Memory Size	512KB (512K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	64K x 8
Voltage - Supply (Vcc/Vdd)	3V ~ 3.6V
Data Converters	A/D 8x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	144-LQFP
Supplier Device Package	144-LQFP (20x20)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/pcf52258cag66

Table of Contents

1 Family Configurations

Table 1. MCF52259 Family Configurations

Module	52252	52254	52255	52256	52258	52259
Version 2 ColdFire Core with eMAC (Enhanced multiply-accumulate unit) and CAU (Cryptographic acceleration unit)	•	•	•	•	•	•
System Clock	up to 66 or 80 MHz[1]		up to 80 MHz[1]	up to 66 or 80 MHz[1]		up to 80 MHz[1]
Performance (Dhrystone 2.1 MIPS)	up to 63 or 76					
Flash	256 KB	512 KB	512 KB	256 KB	512 KB	512 KB
Static RAM (SRAM)	32 KB	64 KB	64 KB	32 / 64 KB	64 KB	64 KB
Two Interrupt Controllers (INTC)	•	•	•	•	•	•
Fast Analog-to-Digital Converter (ADC)	•	•	•	•	•	•
USB On-The-Go (USB OTG)	•	•	•	•	•	•
Mini-FlexBus external bus interface	—	—	—	•	•	•
Fast Ethernet Controller (FEC)	•	•	•	•	•	•
Random Number Generator and Cryptographic Acceleration Unit (CAU)	—	—	•	—	—	•
FlexCAN 2.0B Module	Varies	Varies	•	Varies	Varies	•
Four-channel Direct-Memory Access (DMA)	•	•	•	•	•	•
Software Watchdog Timer (WDT)	•	•	•	•	•	•
Secondary Watchdog Timer	•	•	•	•	•	•
Two-channel Periodic Interrupt Timer (PIT)	2	2	2	2	2	2
Four-Channel General Purpose Timer (GPT)	•	•	•	•	•	•
32-bit DMA Timers	4	4	4	4	4	4
QSPI	•	•	•	•	•	•
UART(s)	3	3	3	3	3	3
I2C	2	2	2	2	2	2
Eight/Four-channel 8/16-bit PWM Timer	•	•	•	•	•	•
General Purpose I/O Module (GPIO)	•	•	•	•	•	•
Chip Configuration and Reset Controller Module	•	•	•	•	•	•
Background Debug Mode (BDM)	•	•	•	•	•	•
JTAG - IEEE 1149.1 Test Access Port	•	•	•	•	•	•
Package	100 LQFP			144 LQFP or 144 MAPBGA		

[1] 66 MHz = 63 MIPS; 80 MHz = 76 MIPS

  - Up to 80 MHz processor core frequency
  - 40 MHz or 33 MHz peripheral bus frequency
  - Sixteen general-purpose, 32-bit data and address registers
  - Implements ColdFire ISA_A with extensions to support the user stack pointer register and four new instructions for improved bit processing (ISA_A+)
  - Enhanced Multiply-Accumulate (EMAC) unit with four 32-bit accumulators to support 16×16 → 32 or 32×32 → 48 operations
  - Cryptographic Acceleration Unit (CAU)
    - Tightly-coupled coprocessor to accelerate software-based encryption and message digest functions
    - Support for DES, 3DES, AES, MD5, and SHA-1 algorithms
- System debug support
  - Real-time trace for determining dynamic execution path
  - Background debug mode (BDM) for in-circuit debugging (DEBUG_B+)
  - Real-time debug support, with six hardware breakpoints (4 PC, 1 address and 1 data) configurable into a 1- or 2-level trigger
- On-chip memories
  - Up to 64 KB dual-ported SRAM on CPU internal bus, supporting core, DMA, and USB access with standby power supply support for the first 16 KB
  - Up to 512 KB of interleaved flash memory supporting 2-1-1-1 accesses
- Power management
  - Fully static operation with processor sleep and whole chip stop modes
  - Rapid response to interrupts from the low-power sleep mode (wake-up feature)
  - Clock enable/disable for each peripheral when not used (except backup watchdog timer)
  - Software controlled disable of external clock output for low-power consumption
- FlexCAN 2.0B module
  - Based on and includes all existing features of the Freescale TouCAN module
  - Full implementation of the CAN protocol specification version 2.0B
    - Standard data and remote frames (up to 109 bits long)
    - Extended data and remote frames (up to 127 bits long)
    - Zero to eight bytes data length
    - Programmable bit rate up to 1 Mbit/s
  - Flexible message buffers (MBs), totalling up to 16 message buffers of 0–8 byte data length each, configurable as Rx or Tx, all supporting standard and extended messages
  - Unused MB space can be used as general purpose RAM space
  - Listen-only mode capability
  - Content-related addressing
  - No read/write semaphores
  - Three programmable mask registers: global for MBs 0–13, special for MB14, and special for MB15
  - Programmable transmit-first scheme: lowest ID or lowest buffer number
  - Time stamp based on 16-bit free-running timer
  - Global network time, synchronized by a specific message
  - Maskable interrupts
- Universal Serial Bus On-The-Go (USB OTG) dual-mode host and device controller
  - Full-speed / low-speed host controller
  - USB 1.1 and 2.0 compliant full-speed / low speed device controller
  - 16 bidirectional end points

  - DMA or FIFO data stream interfaces
  - Low power consumption
  - OTG protocol logic
- Fast Ethernet controller (FEC)
  - 10/100 BaseT/TX capability, half duplex or full duplex
  - On-chip transmit and receive FIFOs
  - Built-in dedicated DMA controller
  - Memory-based flexible descriptor rings
- Mini-FlexBus
  - External bus interface available on 144 pin packages
  - Supports glueless interface with 8-bit ROM/flash/SRAM/simple slave peripherals. Can address up to 2 MB of addresses
  - 2 chip selects ($\overline{\text{FB\_CS}}$[1:0])
  - Non-multiplexed mode: 8-bit dedicated data bus, 20-bit address bus
  - Multiplexed mode: 16-bit data and 20-bit address bus
  - FB_CLK output to support synchronous memories
  - Programmable base address, size, and wait states to support slow peripherals
  - Operates at up to 40 MHz (bus clock) in 1:2 mode or up to 80 MHz (core clock) in 1:1 mode
- Three universal asynchronous/synchronous receiver transmitters (UARTs)
  - 16-bit divider for clock generation
  - Interrupt control logic with maskable interrupts
  - DMA support
  - Data formats can be 5, 6, 7, or 8 bits with even, odd, or no parity
  - Up to two stop bits in 1/16 increments
  - Error-detection capabilities
  - Modem support includes request-to-send (RTS) and clear-to-send (CTS) lines for two UARTs
  - Transmit and receive FIFO buffers
- Two I2C modules
  - Interchip bus interface for EEPROMs, LCD controllers, A/D converters, and keypads
  - Fully compatible with industry-standard I2C bus
  - Master and slave modes support multiple masters
  - Automatic interrupt generation with programmable level
- Queued serial peripheral interface (QSPI)
  - Full-duplex, three-wire synchronous transfers
  - Up to three chip selects available
  - Master mode operation only
  - Programmable bit rates up to half the CPU clock frequency
  - Up to 16 pre-programmed transfers
- Fast analog-to-digital converter (ADC)
  - Eight analog input channels
  - 12-bit resolution
  - Minimum 1.125 μs conversion time
  - Simultaneous sampling of two channels for motor control applications
  - Single-scan or continuous operation
  - Optional interrupts on conversion complete, zero crossing (sign change), or under/over low/high limit

  - Unused analog channels can be used as digital I/O
- Four 32-bit timers with DMA support
  - 12.5 ns resolution at 80 MHz
  - Programmable sources for clock input, including an external clock option
  - Programmable prescaler
  - Input capture capability with programmable trigger edge on input pin
  - Output compare with programmable mode for the output pin
  - Free run and restart modes
  - Maskable interrupts on input capture or output compare
  - DMA trigger capability on input capture or output compare
- Four-channel general purpose timer
  - 16-bit architecture
  - Programmable prescaler
  - Output pulse-widths variable from microseconds to seconds
  - Single 16-bit input pulse accumulator
  - Toggle-on-overflow feature for pulse-width modulator (PWM) generation
  - One dual-mode pulse accumulation channel
- Pulse-width modulation timer
  - Support for PCM mode (resulting in superior signal quality compared to conventional PWM)
  - Operates as eight channels with 8-bit resolution or four channels with 16-bit resolution
  - Programmable period and duty cycle
  - Programmable enable/disable for each channel
  - Software selectable polarity for each channel
  - Period and duty cycle are double buffered. Change takes effect when the end of the current period is reached (PWM counter reaches zero) or when the channel is disabled.
  - Programmable center or left aligned outputs on individual channels
  - Four clock sources (A, B, SA, and SB) provide for a wide range of frequencies
  - Emergency shutdown
- Two periodic interrupt timers (PITs)
  - 16-bit counter
  - Selectable as free running or count down
- Real-Time Clock (RTC)
  - Maintains system time-of-day clock
  - Provides stopwatch and alarm interrupt functions
  - Standby power supply (Vstby) keeps the RTC running when the system is shut down
- Software watchdog timer
  - 32-bit counter
  - Low-power mode support
- Backup watchdog timer (BWT)
  - Independent timer that can be used to help software recover from runaway code
  - 16-bit counter
  - Low-power mode support
- Clock generation features
  - Crystal, on-chip trimmed relaxation oscillator, or external oscillator reference options
  - Trimmed relaxation oscillator

The ADC can be configured to perform a single scan and halt, a scan when triggered, or a programmed scan sequence repeatedly until manually stopped.

The ADC can be configured for sequential or simultaneous conversion. When configured for sequential conversions, up to eight channels can be sampled and stored in any order specified by the channel list register. Both ADCs may be required during a scan, depending on the inputs to be sampled.

During a simultaneous conversion, both S/H circuits are used to capture two different channels at the same time. This configuration requires that a single channel may not be sampled by both S/H circuits simultaneously.

Optional interrupts can be generated at the end of the scan sequence if a channel is out of range (measures below the low threshold limit or above the high threshold limit set in the limit registers) or at several different zero crossing conditions.

1.2.16 DMA Timers (DTIM0–DTIM3)

There are four independent, DMA transfer capable 32-bit timers (DTIM0, DTIM1, DTIM2, and DTIM3) on the device. Each module incorporates a 32-bit timer with a separate register set for configuration and control. The timers can be configured to operate from the system clock or from an external clock source using one of the DTIN*n* signals. If the system clock is selected, it can be divided by 16 or 1. The input clock is further divided by a user-programmable 8-bit prescaler that clocks the actual timer counter register (TCR*n*). Each of these timers can be configured for input capture or reference (output) compare mode. Timer events may optionally cause interrupt requests or DMA transfers.

1.2.17 General Purpose Timer (GPT)

The general purpose timer (GPT) is a four-channel timer module consisting of a 16-bit programmable counter driven by a seven-stage programmable prescaler. Each of the four channels can be configured for input capture or output compare. Additionally, channel three, can be configured as a pulse accumulator.

A timer overflow function allows software to extend the timing capability of the system beyond the 16-bit range of the counter. The input capture and output compare functions allow simultaneous input waveform measurements and output waveform generation. The input capture function can capture the time of a selected transition edge. The output compare function can generate output waveforms and timer software delays. The 16-bit pulse accumulator can operate as a simple event counter or a gated time accumulator.

1.2.18 Periodic Interrupt Timers (PIT0 and PIT1)

The two periodic interrupt timers (PIT0 and PIT1) are 16-bit timers that provide interrupts at regular intervals with minimal processor intervention. Each timer can count down from the value written in its PIT modulus register or it can be a free-running down-counter.

1.2.19 Real-Time Clock (RTC)

The Real-Time Clock (RTC) module maintains the system (time-of-day) clock and provides stopwatch, alarm, and interrupt functions. It includes full clock features: seconds, minutes, hours, days and supports a host of time-of-day interrupt functions along with an alarm interrupt.

1.2.20 Pulse-Width Modulation (PWM) Timers

The device has an 8-channel, 8-bit PWM timer. Each channel has a programmable period and duty cycle as well as a dedicated counter. Each of the modulators can create independent continuous waveforms with software-selectable duty rates from 0% to 100%. The timer supports PCM mode, which results in superior signal quality when compared to that of a conventional PWM. The PWM outputs have programmable polarity, and can be programmed as left aligned outputs or center aligned outputs. For

Table 3. Pin Functions by Primary and Alternate Purpose (continued)

Pin Group	Primary Function	Secondary Function (Alt 1)	Tertiary Function (Alt 2)	Quaternary Function (GPIO)	Slew Rate	Drive Strength/Control[1]	Pull-up/ Pull-down[2]	Pin on 144 MAPBGA	Pin on 144 LQFP	Pin on 100 LQFP
FEC	FEC_COL	—	—	PTI0	PSRRH[0]	PDSRH[0]	—	B11	109	76
	FEC_CRS	—	—	PTI1	PSRRH[1]	PDSRH[1]	—	B12	108	75
	FEC_RXCLK	—	—	PTI2	PSRRH[2]	PDSRH[2]	—	B8	120	87
	FEC_RXD[3:0]	—	—	PTI[6:3]	PSRRH[6:3]	PDSRH[6:3]	—	D7, C7, B7, A8	127, 126, 123, 122	94, 93, 90, 89
	FEC_RXDV	—	—	PTI7	PSRRH[7]	PDSRH[7]	—	C8	121	88
	FEC_RXER	—	—	PTJ0	PSRRH[8]	PDSRH[8]	—	A9	119	86
	FEC_TXCLK	—	—	PTJ1	PSRRH[9]	PDSRH[9]	—	B9	117	84
	FEC_TXD[3:0]	—	—	PTJ[5:2]	PSRRH[13:10]	PDSRH[13:10]	—	A11, B10, C9, D9	110–113	77, 78, 79, 80
FEC	FEC_TXEN	—	—	PTJ6	PSRRH[14]	PDSRH[14]	—	A10	116	83
	FEC_TXER	—	—	PTJ7	PSRRH[15]	PDSRH[15]	—	D8	118	85
I2C0[3]	I2C_SCL0	—	UTXD2	PAS0	PSRR[0]	PDSR[0]	Pull-Up[4]	H1	28	22
	I2C_SDA0	—	URXD2	PAS1	PSRR[0]	PDSR[0]	Pull-Up[4]	H2	29	23
Interrupts	IRQ7	—	—	PNQ7	Low	Low	Pull-Up[4]	E12	96	63
	IRQ5	FEC_MDC	—	PNQ5	Low	Low	Pull-Up[4]	A7	128	95
	IRQ3	FEC_MDIO	—	PNQ3	Low	Low	Pull-Up[4]	A6	129	96
	IRQ1	—	USB_ALTCLK	PNQ1	Low	High	Pull-Up[4]	E9	103	70
JTAG/BDM	JTAG_EN	—	—	—	N/A	N/A	Pull-Down	M2	44	32
	TCLK/ PSTCLK/ CLKOUT	—	FB_CLK	—	Low	Low	Pull-Up[5]	M3	43	31
	TDI/DSI	—	—	—	N/A	N/A	Pull-Up[5]	L1	40	28
	TDO/DSO	—	—	—	Low	Low	—	L2	41	29
	TMS/$\overline{\text{BKPT}}$	—	—	—	N/A	N/A	Pull-Up[5]	K1	38	26
	$\overline{\text{TRST}}$/DSCLK	—	—	—	N/A	N/A	Pull-Up[5]	K2	39	27

2 Electrical Characteristics

This section contains electrical specification tables and reference timing diagrams for the microcontroller unit, including detailed information on power considerations, DC/AC electrical characteristics, and AC timing specifications.

NOTE

The parameters specified in this data sheet supersede any values found in the module specifications.

2.1 Maximum Ratings

Table 4. Absolute Maximum Ratings[1, 2]

Rating	Symbol	Value	Unit
Supply voltage	V_{DD}	–0.3 to +4.0	V
Clock synthesizer supply voltage	V_{DDPLL}	–0.3 to +4.0	V
RAM standby supply voltage	V_{STBY}	+1.8 to 3.5	V
USB standby supply voltage	V_{DDUSB}	–0.3 to +4.0	V
Digital input voltage [3]	V_{IN}	–0.3 to +4.0	V
EXTAL pin voltage	V_{EXTAL}	0 to 3.3	V
XTAL pin voltage	V_{XTAL}	0 to 3.3	V
Instantaneous maximum current Single pin limit (applies to all pins)[4, 5]	I_{DD}	25	mA
Operating temperature range (packaged)	T_A (T_L - T_H)	–40 to 85 or 0 to 70[6]	°C
Storage temperature range	T_{stg}	–65 to 150	°C

1 Functional operating conditions are given in DC Electrical Specifications. Absolute Maximum Ratings are stress ratings only, and functional operation at the maxima is not guaranteed. Stress beyond those listed may affect device reliability or cause permanent damage to the device.

2 This device contains circuitry protecting against damage due to high static voltage or electrical fields; however, it is advised that normal precautions be taken to avoid application of any voltages higher than maximum-rated voltages to this high-impedance circuit. Reliability of operation is enhanced if unused inputs are tied to an appropriate logic voltage level (V_{SS} or V_{DD}).

3 Input must be current limited to the I_{DD} value specified. To determine the value of the required current-limiting resistor, calculate resistance values for positive and negative clamp voltages, then use the larger of the two values.

4 All functional non-supply pins are internally clamped to V_{SS} and V_{DD}.

5 The power supply must maintain regulation within operating V_{DD} range during instantaneous and operating maximum current conditions. If positive injection current ($V_{in} > V_{DD}$) is greater than I_{DD}, the injection current may flow out of V_{DD} and could result in the external power supply going out of regulation. Ensure that the external V_{DD} load shunts current greater than maximum injection current. This is the greatest risk when the MCU is not consuming power (e.g., no clock).

6 Depending on the packaging; see orderable part number summary (Table 2)

2.2 Current Consumption

Table 5. Typical Active Current Consumption Specifications

Characteristic	Symbol	Typical[1] Active (SRAM)	Typical[1] Active (Flash)	Peak[2] (Flash)	Unit
PLL @ 8 MHz	I_{DD}	22	30	36	mA
PLL @ 16 MHz		31	45	60	
PLL @ 64 MHz		84	100	155	
PLL @ 80 MHz		102	118	185	
RAM standby supply current • Normal operation: $V_{DD} > V_{STBY}$ - 0.3 V • Standby operation: $V_{DD} < V_{SS}$ + 0.5 V	I_{STBY}	— —		5 20	μA μA
Analog supply current • Normal operation	I_{DDA}	2 [3]		15	mA
USB supply current	I_{DDUSB}	—		2	mA
PLL supply current	I_{DDPLL}	—		6 [4]	mA

1 Tested at room temperature with CPU polling a status register. All clocks were off except the UART and CFM (when running from flash memory).

2 Peak current measured with all modules active, CPU polling a status register, and default drive strength with matching load.

3 Tested using Auto Power Down (APD), which powers down the ADC between conversions; ADC running at 4 MHz in Once Parallel mode with a sample rate of 3 kHz.

4 Tested with the PLL MFD set to 7 (max value). Setting the MFD to a lower value results in lower current consumption.

Table 6. Current Consumption in Low-Power Mode, Code From Flash Memory[1,2,3]

Mode	8 MHz (Typ)	16 MHz (Typ)	64 MHz (Typ)	80 MHz (Typ)	Unit	Symbol
Stop mode 3 (Stop 11)[4]	0.150				mA	I_{DD}
Stop mode 2 (Stop 10)[4]	7.0					
Stop mode 1 (Stop 01)[4,5]	9	10	15	17		
Stop mode 0 (Stop 00)[5]	9	10	15	17		
Wait / Doze	21	32	56	65		
Run	23	36	70	81		

1 All values are measured with a 3.30 V power supply. Tests performed at room temperature.

2 Refer to the Power Management chapter in the *MCF52259 Reference Manual* for more information on low-power modes.

3 CLKOUT, PST/DDATA signals, and all peripheral clocks except UART0 and CFM off before entering low-power mode. CLKOUT is disabled.

4 See the description of the Low-Power Control Register (LPCR) in the *MCF52259 Reference Manual* for more information on stop modes 0–3.

5 Results are identical to STOP 00 for typical values because they only differ by CLKOUT power consumption. CLKOUT is already disabled in this instance prior to entering low-power mode.

Table 7. Current Consumption in Low-Power Mode, Code From SRAM[1,2,3]

Mode	8 MHz (Typ)	16 MHz (Typ)	64 MHz (Typ)	80 MHz (Typ)	Unit	Symbol
Stop mode 3 (Stop 11)[4]	0.090				mA	I_{DD}
Stop mode 2 (Stop 10)[4]	7					
Stop mode 1 (Stop 01)[4,5]	9	10	15	17		
Stop mode 0 (Stop 00)[5]	9	10	15	17		
Wait / Doze	13	18	42	50		
Run	16	21	55	65		

1 All values are measured with a 3.3 V power supply. Tests performed at room temperature.
2 Refer to the Power Management chapter in the *MCF52259 Reference Manual* for more information on low-power modes.
3 CLKOUT, PST/DDATA signals, and all peripheral clocks except UART0 off before entering low-power mode. CLKOUT is disabled. Code executed from SRAM with flash memory shut off by writing 0x0 to the FLASHBAR register.
4 See the description of the Low-Power Control Register (LPCR) in the *MCF52259 Reference Manual* for more information on stop modes 0–3.
5 Results are identical to STOP 00 for typical values because they only differ by CLKOUT power consumption. CLKOUT is already disabled in this instance prior to entering low-power mode.

2.3 Thermal Characteristics

Table 8 lists thermal resistance values.

Table 8. Thermal Characteristics

	Characteristic		Symbol	Value	Unit
144 MAPBGA	Junction to ambient, natural convection	Single layer board (1s)	θ_{JA}	53[1,2]	°C/W
	Junction to ambient, natural convection	Four layer board (2s2p)	θ_{JA}	30[1,3]	°C/W
	Junction to ambient, (@200 ft/min)	Single layer board (1s)	θ_{JMA}	43[1,3]	°C/W
	Junction to ambient, (@200 ft/min)	Four layer board (2s2p)	θ_{JMA}	26[1,3]	°C/W
	Junction to board	—	θ_{JB}	16[4]	°C/W
	Junction to case	—	θ_{JC}	9[5]	°C/W
	Junction to top of package	Natural convection	Ψ_{jt}	2[6]	°C/W
	Maximum operating junction temperature	—	T_j	105	°C
144 LQFP	Junction to ambient, natural convection	Single layer board (1s)	θ_{JA}	44[7,8]	°C/W
	Junction to ambient, natural convection	Four layer board (2s2p)	θ_{JA}	35[1,9]	°C/W
	Junction to ambient, (@200 ft/min)	Single layer board (1s)	θ_{JMA}	35[1,3]	°C/W
	Junction to ambient, (@200 ft/min)	Four layer board (2s2p)	θ_{JMA}	29[1,3]	°C/W
	Junction to board	—	θ_{JB}	23[10]	°C/W
	Junction to case	—	θ_{JC}	7[11]	°C/W
	Junction to top of package	Natural convection	Ψ_{jt}	2[12]	°C/W
	Maximum operating junction temperature	—	T_j	105	°C

Table 8. Thermal Characteristics (continued)

	Characteristic		Symbol	Value	Unit
100 LQFP	Junction to ambient, natural convection	Single layer board (1s)	θ_{JA}	53[13,14]	°C/W
	Junction to ambient, natural convection	Four layer board (2s2p)	θ_{JA}	39[1,15]	°C/W
	Junction to ambient, (@200 ft/min)	Single layer board (1s)	θ_{JMA}	42[1,3]	°C/W
	Junction to ambient, (@200 ft/min)	Four layer board (2s2p)	θ_{JMA}	33[1,3]	°C/W
	Junction to board	—	θ_{JB}	25[16]	°C/W
	Junction to case	—	θ_{JC}	9[17]	°C/W
	Junction to top of package	Natural convection	Ψ_{jt}	2[18]	°C/W
	Maximum operating junction temperature	—	T_j	105	°C

1 θ_{JA} and Ψ_{jt} parameters are simulated in conformance with EIA/JESD Standard 51-2 for natural convection. Freescale recommends the use of θ_{JA} and power dissipation specifications in the system design to prevent device junction temperatures from exceeding the rated specification. System designers should be aware that device junction temperatures can be significantly influenced by board layout and surrounding devices. Conformance to the device junction temperature specification can be verified by physical measurement in the customer's system using the Ψ_{jt} parameter, the device power dissipation, and the method described in EIA/JESD Standard 51-2.

2 Per JEDEC JESD51-2 with the single-layer board (JESD51-3) horizontal.

3 Per JEDEC JESD51-6 with the board JESD51-7) horizontal.

4 Thermal resistance between the die and the printed circuit board in conformance with JEDEC JESD51-8. Board temperature is measured on the top surface of the board near the package.

5 Thermal resistance between the die and the case top surface as measured by the cold plate method (MIL SPEC-883 Method 1012.1).

6 Thermal characterization parameter indicating the temperature difference between package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written in conformance with Psi-JT.

7 θ_{JA} and Ψ_{jt} parameters are simulated in conformance with EIA/JESD Standard 51-2 for natural convection. Freescale recommends the use of θ_{JA} and power dissipation specifications in the system design to prevent device junction temperatures from exceeding the rated specification. System designers should be aware that device junction temperatures can be significantly influenced by board layout and surrounding devices. Conformance to the device junction temperature specification can be verified by physical measurement in the customer's system using the Ψ_{jt} parameter, the device power dissipation, and the method described in EIA/JESD Standard 51-2.

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12 Thermal characterization parameter indicating the temperature difference between package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written in conformance with Psi-JT.

13 θ_{JA} and Ψ_{jt} parameters are simulated in conformance with EIA/JESD Standard 51-2 for natural convection. Freescale recommends the use of θ_{JA} and power dissipation specifications in the system design to prevent device junction temperatures from exceeding the rated specification. System designers should be aware that device junction temperatures can be significantly influenced by board layout and surrounding devices. Conformance to the device junction temperature specification can be verified by physical measurement in the customer's system using the Ψ_{jt} parameter, the device power dissipation, and the method described in EIA/JESD Standard 51-2.

14 Per JEDEC JESD51-2 with the single-layer board (JESD51-3) horizontal.

15 Per JEDEC JESD51-6 with the board JESD51-7) horizontal.

2.8 Clock Source Electrical Specifications

Table 14. Oscillator and PLL Specifications

(V_{DD} and V_{DDPLL} = 3.0 to 3.6 V, V_{SS} = V_{SSPLL} = 0 V)

Characteristic	Symbol	Min	Max	Unit
Clock Source Frequency Range of EXTAL Frequency Range • Crystal • External[1]	 $f_{crystal}$ f_{ext}	 12 0	 25.0[2] 66.67 or 80	MHz
PLL reference frequency range	f_{ref_pll}	2	10.0	MHz
System frequency [3] • External clock mode • On-chip PLL frequency	f_{sys}	 0 f_{ref} / 32	 66.67 or 80[4] 66.67 or 80[4]	MHz
Loss of reference frequency [5, 7]	f_{LOR}	100	1000	kHz
Self clocked mode frequency [6]	f_{SCM}	1	5	MHz
Crystal start-up time [7, 8]	t_{cst}	—	0.1	ms
EXTAL input high voltage • External reference	V_{IHEXT}	 2.0	 3.0[2]	V
EXTAL input low voltage • External reference	V_{ILEXT}	 V_{SS}	 0.8	V
PLL lock time[4,9]	t_{lpll}	—	500	µs
Duty cycle of reference [4]	t_{dc}	40	60	% f_{ref}
Frequency un-LOCK range	f_{UL}	–1.5	1.5	% f_{ref}
Frequency LOCK range	f_{LCK}	–0.75	0.75	% f_{ref}
CLKOUT period jitter [4, 5, 10 ,11], measured at f_{SYS} Max • Peak-to-peak (clock edge to clock edge) • Long term (averaged over 2 ms interval)	C_{jitter}	 — —	 10 .01	% f_{sys}
On-chip oscillator frequency	f_{oco}	7.84	8.16	MHz

1 In external clock mode, it is possible to run the chip directly from an external clock source without enabling the PLL.

2 This value has been updated.

3 All internal registers retain data at 0 Hz.

4 Depending on packaging; see the orderable part number summary (Table 2).

5 Loss of Reference Frequency is the reference frequency detected internally, which transitions the PLL into self clocked mode.

6 Self clocked mode frequency is the frequency at which the PLL operates when the reference frequency falls below f_{LOR} with default MFD/RFD settings.

7 This parameter is characterized before qualification rather than 100% tested.

8 Proper PC board layout procedures must be followed to achieve specifications.

9 This specification applies to the period required for the PLL to relock after changing the MFD frequency control bits in the synthesizer control register (SYNCR).

10 Jitter is the average deviation from the programmed frequency measured over the specified interval at maximum f_{sys}. Measurements are made with the device powered by filtered supplies and clocked by a stable external clock signal. Noise injected into the PLL circuitry via V_{DDPLL} and V_{SSPLL} and variation in crystal oscillator frequency increase the C_{jitter} percentage for a given interval.

11 Based on slow system clock of 40 MHz measured at f_{sys} max.

2.9 USB Operation

Table 15. USB Operation Specifications

Characteristic	Symbol	Value	Unit
Minimum core speed for USB operation	$f_{sys\_USB\_min}$	16	MHz

2.10 Mini-FlexBus External Interface Specifications

A multi-function external bus interface called Mini-FlexBus is provided with basic functionality to interface to slave-only devices up to a maximum bus frequency of 80 MHz. It can be directly connected to asynchronous or synchronous devices such as external boot ROMs, flash memories, gate-array logic, or other simple target (slave) devices with little or no additional circuitry. For asynchronous devices a simple chip-select based interface can be used.

All processor bus timings are synchronous; that is, input setup/hold and output delay are given in respect to the rising edge of a reference clock, MB_CLK. The MB_CLK frequency is half the internal system bus frequency.

The following timing numbers indicate when data is latched or driven onto the external bus, relative to the Mini-FlexBus output clock (MB_CLK). All other timing relationships can be derived from these values.

Table 16. Mini-FlexBus AC Timing Specifications

Num	Characteristic	Min	Max	Unit	Notes
	Frequency of Operation	—	80	MHz	
MB1	Clock Period	12.5	—	ns	
MB2	Output Valid	—	8	ns	[1]
MB3	Output Hold	2	—	ns	[1]
MB4	Input Setup	6	—	ns	[2]
MB5	Input Hold	0	—	ns	[2]

[1] Specification is valid for all MB_A[19:0], MB_D[7:0], $\overline{\text{MB\_CS}}$[1:0], $\overline{\text{MB\_OE}}$, MB_R/$\overline{\text{W}}$, and MB_ALE.

[2] Specification is valid for all MB_D[7:0].

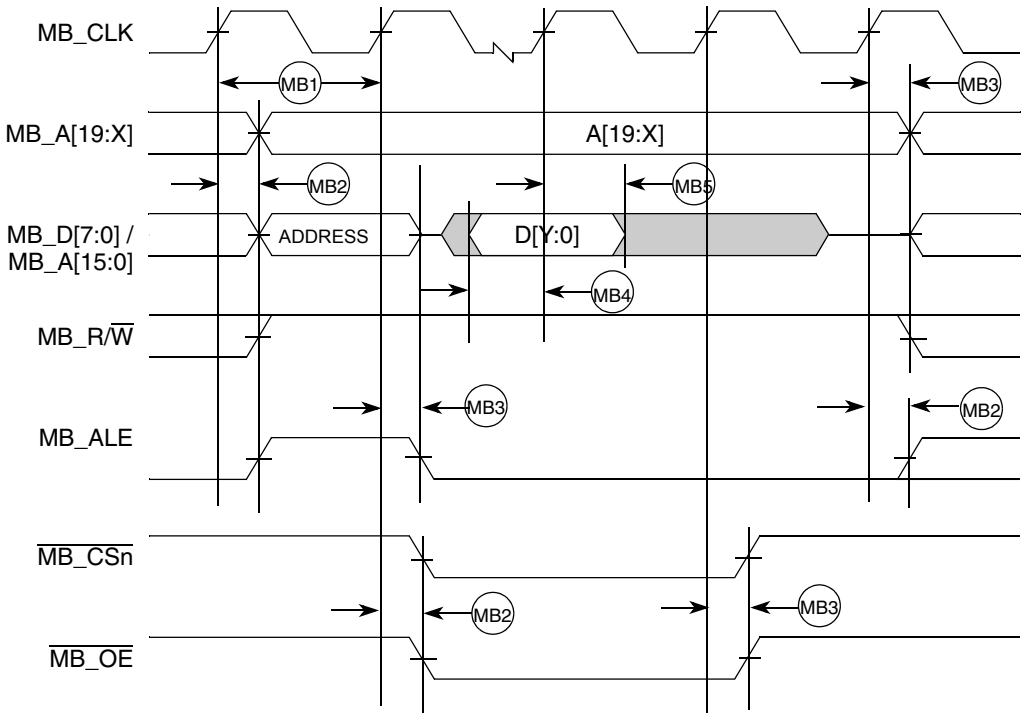

Figure 5. Mini-FlexBus Read Timing

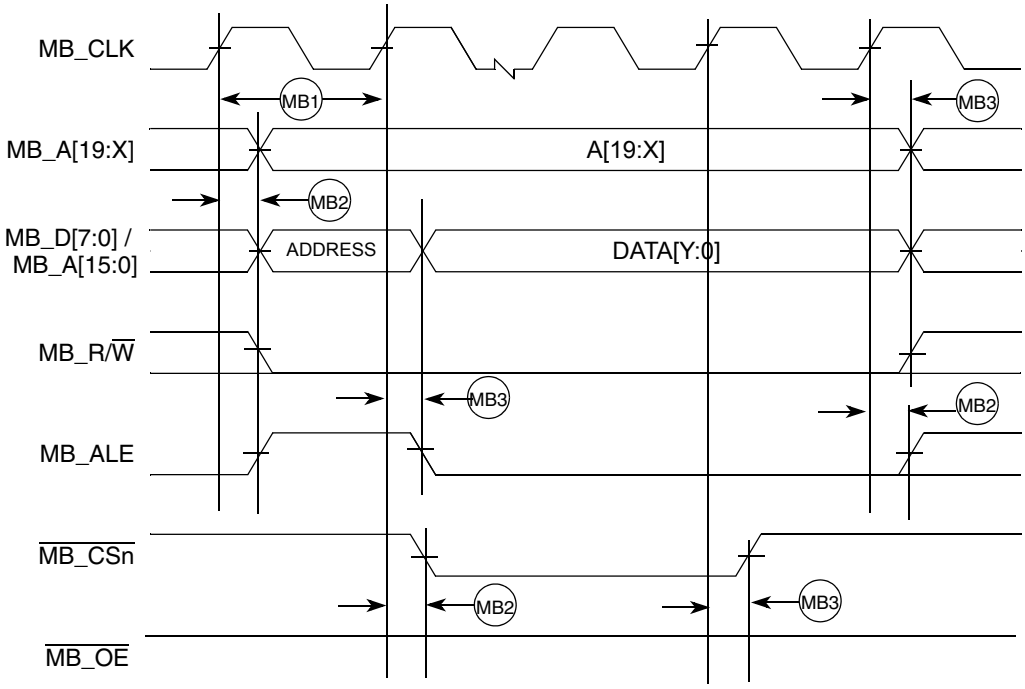

Figure 6. Mini-FlexBus Write Timing

2.11 Fast Ethernet Timing Specifications

The following timing specs are defined at the chip I/O pin and must be translated appropriately to arrive at timing specs/constraints for the physical interface.

- 25 pF / 25 Ω for low drive

Table 21. GPIO Timing

NUM	Characteristic	Symbol	Min	Max	Unit
G1	CLKOUT High to GPIO Output Valid	t_{CHPOV}	—	10	ns
G2	CLKOUT High to GPIO Output Invalid	t_{CHPOI}	1.5	—	ns
G3	GPIO Input Valid to CLKOUT High	t_{PVCH}	9	—	ns
G4	CLKOUT High to GPIO Input Invalid	t_{CHPI}	1.5	—	ns

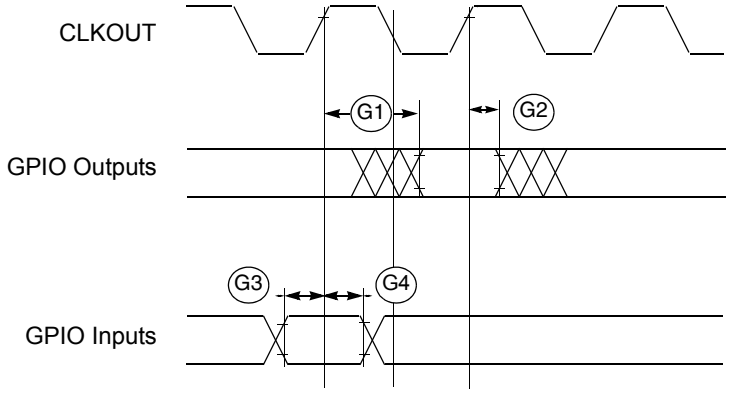

Figure 11. GPIO Timing

2.13 Reset Timing

Table 22. Reset and Configuration Override Timing

(V_{DD} = 3.0 to 3.6 V, V_{SS} = 0 V, $T_A = T_L$ to T_H)[1]

NUM	Characteristic	Symbol	Min	Max	Unit
R1	$\overline{RSTI}$ input valid to CLKOUT High	t_{RVCH}	9	—	ns
R2	CLKOUT High to $\overline{RSTI}$ Input invalid	t_{CHRI}	1.5	—	ns
R3	$\overline{RSTI}$ input valid time [2]	t_{RIVT}	5	—	t_{CYC}
R4	CLKOUT High to $\overline{RSTO}$ Valid	t_{CHROV}	—	10	ns

[1] All AC timing is shown with respect to 50% V_{DD} levels unless otherwise noted.

[2] During low power STOP, the synchronizers for the $\overline{RSTI}$ input are bypassed and $\overline{RSTI}$ is asserted asynchronously to the system. Thus, $\overline{RSTI}$ must be held a minimum of 100 ns.

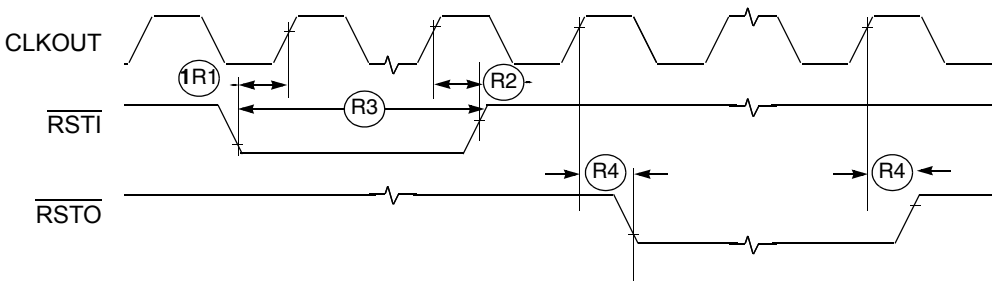

Figure 12. $\overline{RSTI}$ and Configuration Override Timing

Figure 13 shows timing for the values in Table 23 and Table 24.

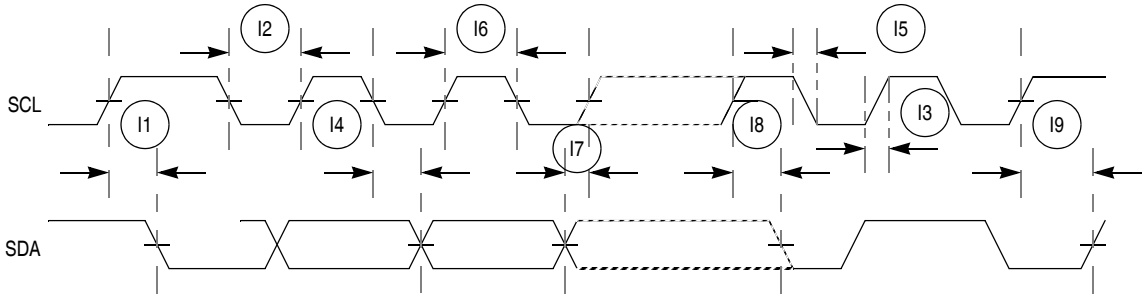

Figure 13. I2C Input/Output Timings

2.15 Analog-to-Digital Converter (ADC) Parameters

Table 25 lists specifications for the analog-to-digital converter.

Table 25. ADC Parameters[1]

Name	Characteristic	Min	Typical	Max	Unit
V_{REFL}	Low reference voltage	V_{SSA}	—	V_{SSA} + 50 mV	V
V_{REFH}	High reference voltage	V_{DDA} - 50 mV	—	V_{DDA}	V
V_{DDA}	ADC analog supply voltage	3.1	3.3	3.6	V
V_{ADIN}	Input voltages	V_{REFL}	—	V_{REFH}	V
RES	Resolution	12	—	12	Bits
INL	Integral non-linearity (full input signal range)[2]	—	±2.5	±3	LSB[3]
INL	Integral non-linearity (10% to 90% input signal range)[4]	—	±2.5	±3	LSB
DNL	Differential non-linearity	—	–1 < DNL < +1	<+1	LSB
Monotonicity		GUARANTEED			
f_{ADIC}	ADC internal clock	0.1	—	5.0	MHz
R_{AD}	Conversion range	V_{REFL}	—	V_{REFH}	V
t_{ADPU}	ADC power-up time[5]	—	6	13	t_{AIC} cycles[6]
t_{REC}	Recovery from auto standby	—	0	1	t_{AIC} cycles
t_{ADC}	Conversion time	—	6	—	t_{AIC} cycles
t_{ADS}	Sample time	—	1	—	t_{AIC} cycles
C_{ADI}	Input capacitance	—	See Figure 14	—	pF
X_{IN}	Input impedance	—	See Figure 14	—	W
I_{ADI}	Input injection current[7], per pin	—	—	3	mA
I_{VREFH}	V_{REFH} current	—	0	—	mA
V_{OFFSET}	Offset voltage internal reference	—	±8	±15	mV
E_{GAIN}	Gain error (transfer path)	.99	1	1.01	—
V_{OFFSET}	Offset voltage external reference	—	±3	9	mV

2.20 Debug AC Timing Specifications

Table 29 lists specifications for the debug AC timing parameters shown in Figure 21.

Table 29. Debug AC Timing Specification

Num	Characteristic	66/80 MHz		Units
		Min	Max	
D1	PST, DDATA to CLKOUT setup	4	—	ns
D2	CLKOUT to PST, DDATA hold	1.5	—	ns
D3	DSI-to-DSCLK setup	$1 \times t_{CYC}$	—	ns
D4[1]	DSCLK-to-DSO hold	$4 \times t_{CYC}$	—	ns
D5	DSCLK cycle time	$5 \times t_{CYC}$	—	ns
D6	$\overline{\text{BKPT}}$ input data setup time to CLKOUT rise	4	—	ns
D7	$\overline{\text{BKPT}}$ input data hold time to CLKOUT rise	1.5	—	ns
D8	CLKOUT high to $\overline{\text{BKPT}}$ high Z	0.0	10.0	ns

1 DSCLK and DSI are synchronized internally. D4 is measured from the synchronized DSCLK input relative to the rising edge of CLKOUT.

Figure 20 shows real-time trace timing for the values in Table 29.

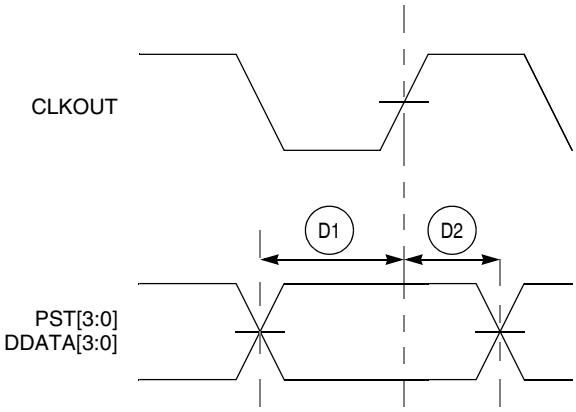

Figure 20. Real-Time Trace AC Timing

Figure 21 shows BDM serial port AC timing for the values in Table 29.

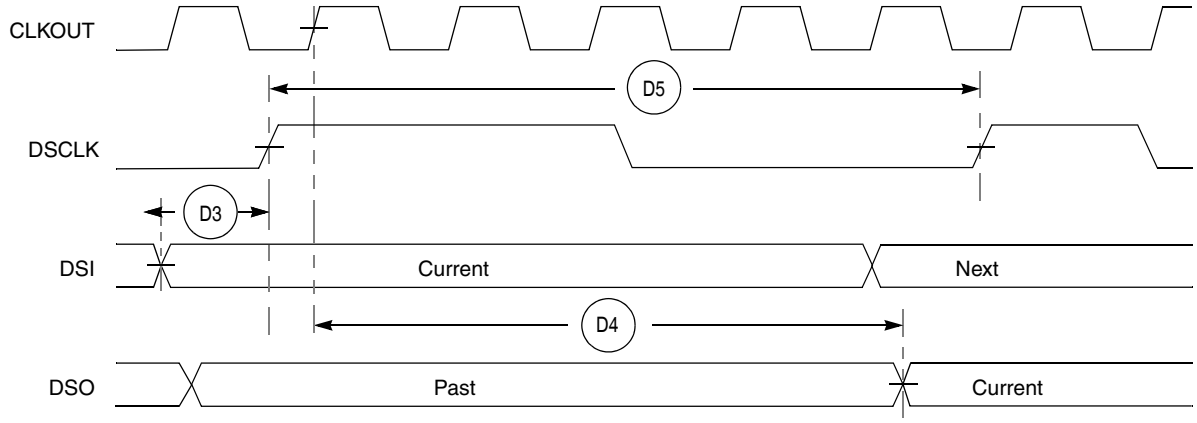

Figure 21. BDM Serial Port AC Timing

3 Package Information

The latest package outline drawings are available on the product summary pages on http://www.freescale.com/coldfire. Table 30 lists the case outline numbers per device. Use these numbers in the web page's keyword search engine to find the latest package outline drawings.

Table 30. Package Information

Device	Package Type	Case Outline Numbers
MCF52252	100 LQFP	98ASS23308W
MCF52254		
MCF52255		
MCF52256	144 LQFP or 144 MAPBGA	98ASS23177W 98ASH70694A
MCF52258		
MCF52259		

4 Revision History

Table 31. Revision History

Revision	Description
0	Initial public release.
1	• Added package dimensions to package diagrams • Added listing of devices for MCF52259 family • Changed “Four-channel general-purpose timer (GPT) capable of input capture/output compare, pulse width modulation (PWM), and pulse accumulation” to “Four-channel general-purpose timer (GPT) capable of input capture/output compare, pulse width modulation (PWM), pulse-code modulation (PCM), and pulse accumulation” • Updated the figure **Pinout Top View (144 MAPBGA)** • Removed an extraneous instance of the table **Pin Functions by Primary and Alternate Purpose** • In the table **Pin Functions by Primary and Alternate Purpose**, changed a footnote from “This list for power and ground does not include those dedicated power/ground pins included elsewhere, such as in the ADC” to “This list for power and ground does not include those dedicated power/ground pins included elsewhere, such as in the ADC, USB, and PLL” • In the table **SGFM Flash Program and Erase Characteristics**, changed “(V_{DDF} = 2.7 to 3.6 V)“ to “(V_{DD} = 3.0 to 3.6 V)“ • In the table **SGFM Flash Module Life Characteristics**, changed “(V_{DDF} = 2.7 to 3.6 V)“ to “(V_{DD} = 3.0 to 3.6 V)“ • In the table **Oscillator and PLL Specifications**, changed “V_{DD} and V_{DDPLL} = 2.7 to 3.6 V“ to “V_{DD} and V_{DDPLL} = 3.0 to 3.6 V“ • In the table **Reset and Configuration Override Timing**, changed “V_{DD} = 2.7 to 3.6 V“ to “V_{DD} = 3.0 to 3.6 V“
2	• Added EzPort Electrical Specifications. • Updated Table 2 for part numbers. • In Table 13, added slew rate column, updated derive strength, pull-up/pull-down values,JTAG pin alternate functions, removed Wired/OR control column, and reordered AN[7:0] list of pin numbers for 144 LQFP and 100 LQFP. • Updated Table 14. • Updated Table 13, to change MIN voltage spec for Standby Voltage (VSTBY) to 1.8V (from 3.0V). • Updated Figure 2 for RTC_EXTAL and RTC_XTAL pin positions.
3	• Updated EzPort Electrical Specifications • Added hysteresis note in the DC electrical table • Clarified pin function table for VSS pins. • Clarified orderable part summary.
4	• Updated EXTAL input high voltage (External reference) Maximum to "3.0V" (Instead of "VDD"). Also, added a footnote saying, “This value has been update” • Updated crystal frequency value to 25 MHz
5	• Updated TOC

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